

## STWA35N65DM2

# N-channel 650 V, 0.093 Ω typ., 32 A MDmesh™ DM2 Power MOSFET in a TO-247 long leads package

Datasheet - production data

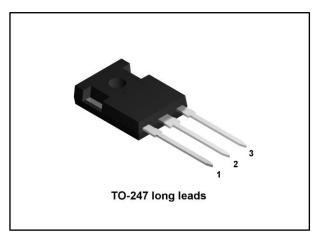
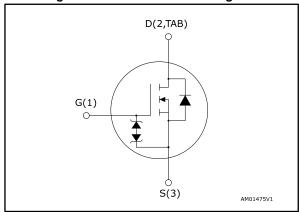


Figure 1: Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	Ртот
STWA35N65DM2	650 V	0.110 Ω	32 A	250 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

### **Applications**

Switching applications

## Description

This high voltage N-channel Power MOSFET is part of the MDmesh™ DM2 fast recovery diode series. It offers very low recovery charge (Q<sub>rr</sub>) and time (t<sub>rr</sub>) combined with low R<sub>DS(on)</sub>, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

**Table 1: Device summary** 

Order code	Marking	Package	Packing
STWA35N65DM2	35N65DM2	TO-247 long leads	Tube

Contents STWA35N65DM2

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STWA35N65DM2 Electrical ratings

# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>G</sub> s	Gate-source voltage	±25	V
l-	Drain current (continuous) at T <sub>case</sub> = 25 °C	32	۸
ID	Drain current (continuous) at T <sub>case</sub> = 100 °C	20	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	90	Α
P <sub>TOT</sub>	Total dissipation at T <sub>case</sub> = 25 °C	250	W
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope 50		V/ns
dv/dt <sup>(3)</sup>	MOSFET dv/dt ruggedness 50		V/IIS
T <sub>stg</sub>	Storage temperature range -55 to 150		°C
Tj	Operating junction temperature range	-55 (0 150	C

#### Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case	0.5	90044
R <sub>thj-amb</sub>	Thermal resistance junction-ambient 50		°C/W

**Table 4: Avalanche characteristics** 

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or non-repetitive	4	Α
E <sub>AS</sub> <sup>(1)</sup>	Single pulse avalanche energy	1150	mJ

#### Notes:

 $^{(1)}Starting~T_{j}=25~^{\circ}C,~I_{D}=I_{AR},~V_{DD}=50~V.$ 

<sup>&</sup>lt;sup>(1)</sup>Pulse width is limited by safe operating area.

 $<sup>^{(2)}</sup>I_{SD} \leq 32$  A, di/dt=900 A/ $\mu$ s, V $_{DS}$  peak < V $_{(BR)DSS}$ , V $_{DD}$  = 80% V $_{(BR)DSS}$ 

 $<sup>^{(3)}</sup>V_{DS} \le 520 \ V$ 

Electrical characteristics STWA35N65DM2

## 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
	Zoro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			1	
IDSS	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V},$ $T_{case} = 125 \text{ °C}^{(1)}$			100	μΑ
Igss	Gate-body leakage current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±25 V			±5	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 16 A		0.093	0.110	Ω

#### Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions		Тур.	Max.	Unit
Ciss	Input capacitance		-	2540	ı	
Coss	Output capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz,	-	115	ı	pF
C <sub>rss</sub>	Reverse transfer capacitance	$V_{GS} = 0 V$	-	2.5	-	Pi
Coss eq. (1)	Equivalent output capacitance	V <sub>DS</sub> = 0 to 520 V, V <sub>GS</sub> = 0 V	-	204	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> = 0 A	-	4.2	-	Ω
$Q_g$	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 32 \text{ A}, V_{GS} = 0$	-	56.3	-	
Qgs	Gate-source charge	to 10 V (see Figure 15: "Test	-	12.7	-	nC
Q <sub>gd</sub>	Gate-drain charge	circuit for gate charge behavior")	-	27.6	-	

#### Notes:

**Table 7: Switching times** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> = 325 V, I <sub>D</sub> = 16 A,		23.4	-	
tr	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 V$ (see Figure 14: "Test circuit for	ı	23	-	
t <sub>d(off)</sub>	Turn-off delay time	resistive load switching times" and Figure 19: "Switching time waveform")	-	72	-	ns
t <sub>f</sub>	Fall time		-	10.4	-	

<sup>&</sup>lt;sup>(1)</sup>Defined by design, not subject to production test.

 $<sup>^{(1)}</sup>$ Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDs increases from 0 to 80% VDss.

Table 8: Source-drain diode

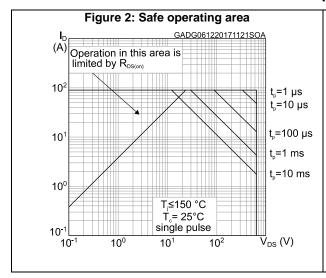
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		32	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		90	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 32 A	-		1.6	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 32 A, di/dt = 100 A/μs,	-	100		ns
Qrr	Reverse recovery charge	V <sub>DD</sub> = 60 V (see Figure 16: "Test circuit for inductive load	-	0.42		μC
I <sub>RRM</sub>	Reverse recovery current	switching and diode recovery times")	-	8.4		Α
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 32 A, di/dt = 100 A/µs,	-	205		ns
Qrr	Reverse recovery charge	V <sub>DD</sub> = 60 V, T <sub>i</sub> = 150 °C (see Figure 16: "Test circuit for		1.8		μC
I <sub>RRM</sub>	Reverse recovery current	inductive load switching and diode recovery times")	-	17.6		Α

#### Notes:

<sup>&</sup>lt;sup>(1)</sup>Pulse width is limited by safe operating area.

 $<sup>^{(2)}\</sup>text{Pulse}$  test: pulse duration = 300  $\mu\text{s},$  duty cycle 1.5%

## 2.1 Electrical characteristics (curves)



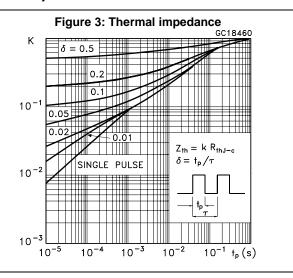
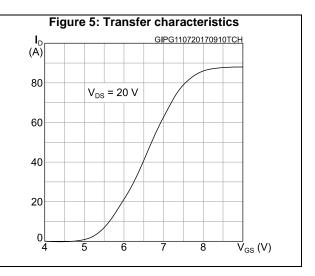
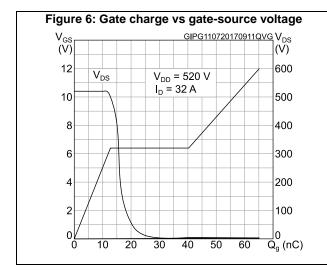


Figure 4: Output characteristics GIPG110720170910OCH  $I_D$ (A) V<sub>GS</sub>= 9, 10 V 80  $V_{GS}$ =8 V60 V<sub>GS</sub>=7 V 40 20 V<sub>GS</sub>=6 V 0 8 12 16  $\overline{V}_{DS}(V)$ 





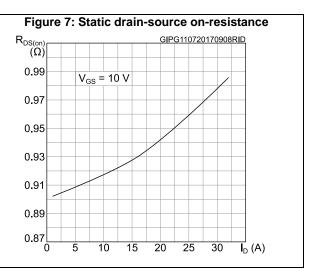
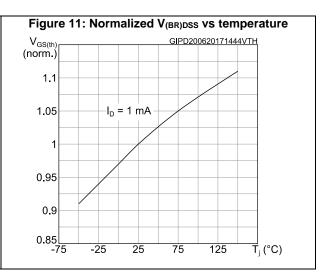
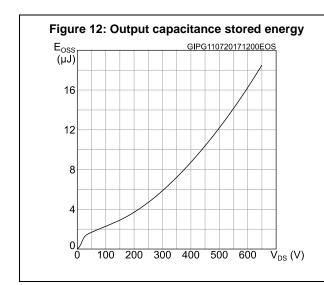
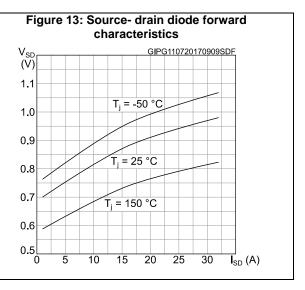


Figure 8: Capacitance variations GIPG110720170909CVR (pF)  $10^{4}$ C<sub>ISS</sub>  $10^{3}$ 10<sup>2</sup> Coss 10<sup>1</sup> f = 1 MHz  $C_{RSS}$ 10<sup>0</sup> 10<sup>-1</sup> 10<sup>0</sup> 10<sup>1</sup> 10<sup>2</sup>  $\vec{V}_{DS}(V)$ 

Figure 9: Normalized gate threshold voltage vs temperature  $V_{GS(th)} = \frac{V_{GS(th)}}{(norm.)} = \frac{GIPD200620171427VTH}{1.1} = \frac{1}{1.1} = \frac{1}{1.1}$ 







Test circuits STWA35N65DM2

## 3 Test circuits

Figure 14: Test circuit for resistive load switching times

Figure 15: Test circuit for gate charge behavior

12 V 47 KΩ 100 Ω D.U.T.

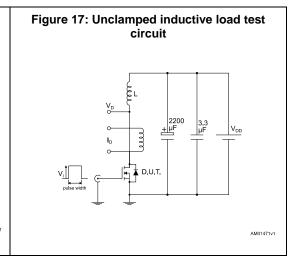
12 V 47 KΩ VGD

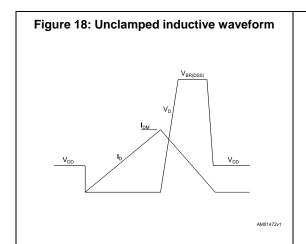
14 V CONST 100 Ω D.U.T.

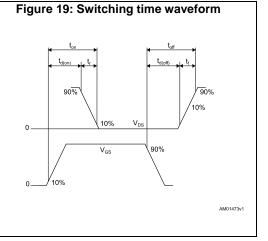
14 V CONST 100 Ω VGD

AM01469v1

Figure 16: Test circuit for inductive load switching and diode recovery times







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# 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

## 4.1 TO-247 long leads package information

HEAT-SINK PLANE øΡ E3 A2-Ď A1. *b2* (3x) b 8463846\_2\_F

Figure 20: TO-247 long leads package outline

Table 9: TO-247 long leads package mechanical data

Dim	3	mm	
Dim.	Min.	Тур.	Max.
Α	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
С	0.59		0.66
D	20.90	21.00	21.10
Е	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
е	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
Р	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25

STWA35N65DM2 Revision history

# 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
21-Jul-2017	1	Initial release
06-Dec-2017	2	Document status changed from preliminary to production data.  Updated Table 2: "Absolute maximum ratings" and Table 8: "Source-drain diode".  Updated Section 2.1: "Electrical characteristics (curves)".  Updated Figure 2: "Safe operating area".  Minor text changes.

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